

Search Notes

Application/Control No.

10/066,024

Examiner

Pablo N. Tran

Applicant(s)/Patent under
Reexamination

BUER ET AL.

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
475	209	07/27/07	P
	313		
	315		
	318-319		
	326		
	318		
	323		
	116		
	118-1		
	119-1		
	120-1		
	502-503		
	423		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East West	07/23/07	
Nguyen V.	↓	↓

Search Notes (continued)

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SEARCHED

Class	Subclass	Date	Examiner
333	1.1	07/23/07	↓
	24.2		
	249-247		
	248		
	260		
343	700MS		
	841		
	YF3		
	701-705		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner